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FORM PTO-1449	APR 1 8 2005	Docket No.: 1436.103.101/IO030904PUS	Serial No.: 10/674,177
LIST OF PATENTS AND INFORMATION	PUBLICATIONS FOR APPLICANTS DISCLOSURE STATEMENT	Applicant: Jonghee Han et al.	
		Filing Date: September 29, 2003	Group Art: 2818 2824

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Examiner Initial		Document No.	Date Name		Class	Sub Class	Filing Date If Appropriate
VTN	AA	6,407,963	06/18/2002	Takahiro et al.			
MIN	AB	6,115,322	09/05/2000	Kanda et al.			
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FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Sub Class	Translated Yes No
•	AM						Yes
	AN			·			Yes
-	AO				<u>l</u>		Yes

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	ΑP	A copy of International Search Report PCT/EP/2004/010747 mailed April 15, 2005 (7 pgs)			
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EXAMI	NER:	Whungn	DATE CONSIDERED: 7/28/05		

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